## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | LEE ET AL. | Examiner | Art Unit | Luz L. Alejandro | 1763 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,842,147	01-2005	Howald et al.	343/701
*	В	US-2006/0027168	02-2006	Matsuda et al.	118/723.001
	С	US-			
	D	US-			
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	F	US-			
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	К	US-			
	Ĺ	US-			
	М	US-			·

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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